

Agilent E8267C PSG Vector Signal Generators

Data Sheet



All specifications and characteristics apply over a 0 to 55 °C range (unless otherwise stated) and apply after a 45 minute warm-up time. Supplemental characteristics, denoted as typical or nominal, provide additional (non-warranted) information.

PSG Signal Generators

	Option 520	Option 540
	250 kHz to 20 GHz	250 kHz to 40 GHz
CW only	E8247C	E8247C
Analog	E8257C	E8257C
Vector	E8267C	

(See E8247C/E8257C data sheet for PSG CW and Analog Signal Generator specifications)

Definitions

Specifications (spec): represent warranted performance.

Typical (typ): performance is not warranted. It applies at 25 °C. A minimum of 80% of all products meet typical performance.

Nominal (nom): values are not warranted. They represent the value of a parameter that is most likely to occur; the expected or mean value. They are included to facilitate the application of the product.

Standard (std): No options are included when referring to the signal generator unless noted otherwise.



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Specifications

Frequency

Range ¹			
Option 520	250 kHz to 20 GHz ²		
Resolution			
CW	0.001 Hz		
All Sweep Modes	0.01 Hz		
Accuracy		effects± line voltage effects	
Switching speed ³	< 12 ms (typical)		
Phase offset	Adjustable in nominal 0.1°	increments.	
Frequency bands			
Band	Frequency range	N #	
1	250 kHz to 250 MHz	1/8	
2	> 250 to 500 MHz	1/16	
3	> 500 MHz to 1 GHz	1/8	
4	> 1 to 2 GHz	1/4	
5	> 2 to 3.2 GHz	1/2	
6	> 3.2 to 10 GHz	1	
7	> 10 to 20 GHz	2	
Internal timebase reference oscillator			
	Standard	Option UNR	
Aging rate	$< \pm 1 \times 10^{-7}$ /year or	$< \pm 3 \times 10^{-8}$ /year or	
	< ±4.5 x 10 ⁻⁹ /day	$< \pm 2.5 \times 10^{-10}/day$	
	after 45 days	after 30 days	
Temperature effects (typical)	< ±5 x 10 ⁻⁸ 0 to 55 °C	< ±4.5 x 10 ⁻⁹ 0 to 55 °C	
Line voltage effects (typical)	< ±2 x 10 ⁻⁹ for	< ±2 x 10 ⁻¹⁰ for	
	+5% -10% change	±10% change	
External reference frequency	1, 2, 2.5, 5, 10 MHz	10 MHz only	
	(within 0.2 ppm)	(within 1 ppm)	
Reference output			
Frequency	10 MHz		
Amplitude	$>$ +4 dBm into 50 Ω load (typical)		
External reference input			
Amplitude	> -3 dBm		
Opt UNR	$5 \text{ dBm } \pm 5 \text{ dB}^4$		
Input impedance	50 Ω (nominal)		

Useable, but unspecified, down to 100 kHz
 In ramp sweep mode (Option 007), resolution is limited with narrow spans and slow sweep speeds.
 Refer to ramp sweep specifications for more information.
 To within 0.1 ppm of final frequency above 250 MHz or within 100 Hz below 250 MHz
 To optimize phase noise 5 dBm ± 2 dB

Digital sweep

Operating modes	Step sweep of frequency or amplitude or both (start to stop)		
	List sweep of frequency or amplitude or both (arbitrary list)		
Sweep range			
Frequency sweep	Within instrument frequency range		
Amplitude sweep	Within attenuator hold range		
Dwell time	1 ms to 60 s		
Number of points	2 to 1601 (step sweep)		
	2 to 1601 per table (list sweep)		
Triggering	Auto, external, single, or GPIB		

Ramp (analog) sweep (Option 007)¹

Iriggering		Auto, external, single, or GPIB		
Operating modes		Synthesized fre	equency sweep	
		(start/stop), (c	enter/span), (swept	CW)
		Power (amplitu	ude) sweep (start/st	top)
		Manual sweep)	
		RPG control be	etween start and sto	p frequencies
		Alternate swee	•	
				een current and stored states
Sweep span range		Settable from i	minimum ² to full rar	
Maximum sweep rate	Start		Maximum	Max span for
	frequen	•	sweep rate	100 ms sweep
	250 kHz	to <0.5 GHz	25 MHz/ms	2.5 GHz
	0.5 to <		50 MHz/ms	5 GHz
	1 to <2		100 MHz/ms	10 GHz
	2 to <3.		200 MHz/ms	20 GHz
	≥3.2 GH		400 MHz/ms	20 GHz
Frequency accuracy			•	00 ms sweep time, for
				values given above)
				as sweep time increases ³
Sweep time		(forward swee	p, not including ban	dswitch and retrace intervals)
Resolution		1 ms		
Manual mode			s to 99 seconds	
Auto mode				by maximum sweep rate
		and 8757D set		
Triggering		Auto, external, single, or GPIB		
	Markers 10 independent continuously variable frequency market			
Display		Z-axis intensity or RF amplitude pulse		
Functions		M1 to center, M1/M2 to start/stop, marker delta		
Two-tone (master/slav	/e)			
measurements ⁴		Two PSGs can synchronously track each other, with		
	independent control of start/stop frequencies		frequencies	
Network analyzer comp	atibility	Fully compatible	e with Agilent 8757I	O scalar network analyzer ⁵
	-		-	C/E scalar network analyzers
		for making bas	sic swept measurem	ents.6
			<u> </u>	

During Ramp sweep operation, AM and Pulse Modulation are useable but not specified; FM, Phase Modulation, Wideband AM and I/Q modulation are not useable.

Minimum settable sweep span is proportional to carrier frequency and sweep time. Actual sweep span
may be slightly different than desired setting for spans less than [0.00004% of carrier frequency or
140 Hz] x [sweep time in seconds]. Actual span will always be displayed correctly.

Typical accuracy for sweep times > 100 ms can be calculated from the equation: [(0.005% of span)/(sweep time in seconds)] ± timebase. Accuracy is not specified for sweep times < 100 ms.

^{4.} For Master/Slave operation use Agilent Technologies part #8120-8806 Master/Slave interface cable.

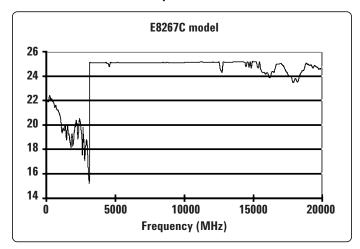
^{5.} When measuring low-pass devices in AC mode, dynamic range may be reduced up to 10dB below 3.2 GHz

GPIB system interface is not supported with 8757A/C/E, only with 8757D. As a result, some features of the 8757A/C/E, such as frequency display, pass-through mode, and alternate sweep, do not function with PSG signal generators.

Output

Power¹ (dBm) Frequency range -130 to +13 250 kHz to $3.2\ GHz^2$ 250 kHz to 3.2 GHz (with Option 1E6)² -130 to +10> 3.2 to 20 GHz³ -130 to +18 0 to 115 dB in 5 dB steps **Step attenuator**

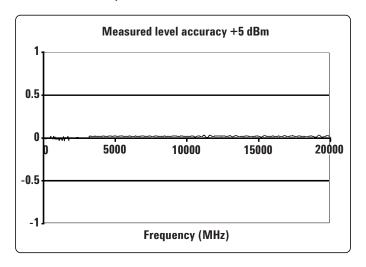
Measured maximum available power in CW mode



Attenuator ho Minimum	ttenuator hold range (Same as max power sweep range) From -15 dBm to maximum specified ou power with step attenuator in 0 dB posit Can be offset using step attenuator.				
Amplitude sw	itching spec	ed ⁴			
CW or analog n	nodulation		< 5 ms (typic	al)	
When using por	wer search		< 25 ms (typ	ical)	
Level accurac	y ⁵ (dB)				
Frequency	> +10 dBm	+10 to –10 dBm	–10 to –70 dBm	–70 to –90 dBm	–90 to –110 dBm
250 kHz to 2 GHz	±0.6	±0.6	±0.7	±0.8	±1.4
> 2 to 20 GHz	±0.8	±0.8	±0.9	±1.0	±1.7
CW Level acc	uracy with	I/Q modulation	(With PRBS r	modulated data)	
(relative to CW)	6				
With ALC On:					
QAM or QPSK formats ⁷ Constant-amplitude formats (FSK, GMSK, etc) With ALC Off: ⁸			± 0.2 dB ± 0.2 dB ± 0.2 dB (typ	oical)	

- Maximum power specification is warranted from 15 to 35 °C, and is typical from 0 to 15 °C. Maximum power over the 35 to 55 °C range typically degrades less than 2 dB
- With I/Q modulation on, maximum power specification is typical. With external inputs enabled,
- $\sqrt{(l^2+Q^2)} > 0.2 \ V_{rms}.$ With l/Q modulation on, maximum power specification is typically +15 dBm. With external inputs enabled,
- $\sqrt{(l^2+\Omega^2)}>0.2\ V_{rms}.$ To within 0.1 dB of final amplitude within one attenuator range
- Specifications apply in CW and list/step sweep modes over the 15 to 35 °C temperature range, with attenuator hold off (normal operating mode). Degradation outside this range, for ALC power levels > -5 dBm, is typically < 0.3 dB. In Ramp sweep mode (with Option 007), specifications are typical. For instruments with Type-N connectors (Option 1ED), specifications are degraded typically 0.2 dB above 18 GHz. Level accuracy is not specified below -110 dBm.
- 6. If external inputs are used, specification applies with input level $\sqrt{(l^2 + Q^2)} = 0.3 \text{ V}_{rms}$ and l/Q modulator attenuation = 10 dB.
- Measured with symbol rate > 10 kHz and power ≤ 0 dBm.
- Relative to ALC on, after power search is executed. When applying external I/Q signals with ALC off, output level will vary directly with I/Q input level.

20 GHz level accuracy



Resolution	0.01 dB	
Temperature stability	0.01 dB/ °C (typical)	
User flatness correction		
Number of points	2 to 1601 points/table	
Number of tables	Up to 10,000, memory limited	
Path loss	Arbitrary, within attenuator range	
Entry modes	Remote power meter ¹ , remote bus, manual	
	(user edit/view)	
Output impedance	50 $Ω$ (nominal)	
SWR (internally leveled, typical)		
250 kHz to 2 GHz	< 1.4:1	
> 2 GHz to 20 GHz	< 1.6:1	
Leveling modes	Internal leveling, external detector leveling, millimeter source module, ALC Off	
External detector leveling		
Range	-0.2 mV to -0.5 V, (nominal) (-36 dBm to +4 dBm using Agilent 33330D/E detector)	
Bandwidth	10 kHz (typical)	
	(Note: not intended for pulsed operation)	
Maximum reverse power	1/2 Watt (nominal)	

^{1.} Compatible with Agilent Technologies EPM Series (E4418B and E4419B) power meters.

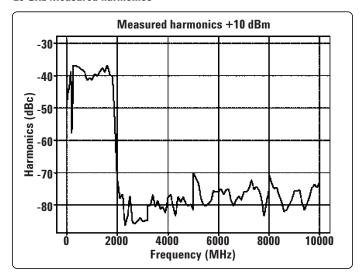
Spectral purity

Harmonics 1 (dBc at +10 dBm or maximum specified output power,

whichever is lower) -27 dBc (typical)

< 1 MHz 1 MHz to 2 GHz -27 dBc > 2 GHz to 20 GHz -55 dBc

20 GHz Measured harmonics



Sub-harmonics ²	Sub-harmonics ² (dBc at +10 dBm or maximum specified output pow			
	whichever is lower)			
250 kHz to 10 GHz	None			
> 10 GHz to 20 GHz	<-60 dBc			
Non-harmonics	(dBc at +10 dBm or maximum specified output pow			
	whichever is lower, for offs	sets > 3 KHz [>300 Hz with		
	Option UNR]) 3	•		
Frequency	Spec	Typical		
250 kHz to 250 MHz	-65	-72 for > 10 kHz offsets		
> 250 MHz to 1 GHz	-80	-88		
> 1 to 2 GHz	-74	-82		
> 2 to 3.2 GHz	-68	-76		
> 3.2 to 10 GHz	-62	-70		
> 10 to 20 GHz	-56	-64		
SSB phase noise (CW)	Offset from carrier (dBc/Ha	<u>z)</u>		
Frequency	20 kHz	20 kHz (typical)		
250 kHz to 250 MHz	-130	-134		
> 250 to 500 MHz	-134^{4}	-138		
> 500 MHz to 1 GHz	-130	-134		
> 1 to 2 GHz	-124	-128		
> 2 to 3.2 GHz	-120	-124		
> 3.2 to 10 GHz	-110	-113		
> 10 to 20 GHz	-104	-108		

Specifications for harmonics beyond maximum instrument frequencies are typical.

Specifications for sub-harmonics beyond maximum instrument frequencies are typical.

Specimental of sub-framions beyond maximum installient requestions are typical.
 Performance is typical for spurs at frequencies above the maximum operating frequency of the instrument. Specifications apply for CW mode only. Performance typically is -60 dBc between 200 and 250 MHz.
 For instruments with serial number prefixes below MY4330 or US4330, the specification is -136 dBc/Hz.

Option UNR: Enhanced SSB phase noise (CW)

Offset from carrier (dBc/Hz)

	Offset from Carrier (abc/112)				
Frequency	100 Hz	1 kHz	10 kHz	100 kHz	
	spec (typical)	spec (typical)	spec (typical)	spec (typical)	
250 kHz to 250 MHz	-94 (-115)	-110 (-123)	-128 (-132)	-130 (-133)	
> 250 to 500 MHz	-100 (-110)	-124 (-130)	-132 (-136)	-136 (-141)	
> 500 MHz to 1 GHz	-94 (-104)	-118 (-126)	-130 (-135)	-130 (-135)	
> 1 to 2 GHz	-88 (-98)	-112 (-120)	-124 (-129)	-124 (-129)	
> 2 to 3.2 GHz	-84 (-94)	-108 (-116)	-120 (-125)	-120 (-125)	
> 3.2 to 10 GHz	-74 (- 84)	-98 (-106)	-110 (- 115)	-110 (- 115)	
> 10 to 20 GHz	–68 (–78)	-92 (-100)	-104 (-107)	-104 (-109)	

Residual FM

 $\begin{array}{lll} \text{CW mode} & < \text{N x 8 Hz (typical)} \\ \text{Option UNR} & < \text{N x 4 Hz (typical)} \\ \text{Ramp sweep mode:} & < \text{N x 1 kHz (typical)} \\ \end{array}$

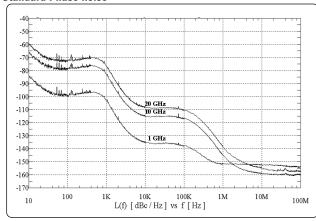
(rms, 50 Hz to 15 kHz bandwidth)

Broadband noise (CW mode at +10 dBm output, for offsets > 10 MHz)

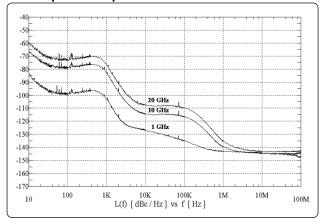
> 2.4 to 20 GHz < -148 dBc/Hz (typical)

Measured phase noise with E5500 and plotted without spurs

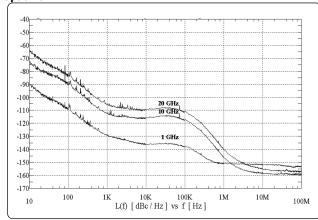
Standard Phase noise



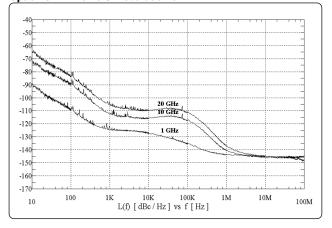
Standard phase noise performance with I/Q modulation on 1



Option UNR

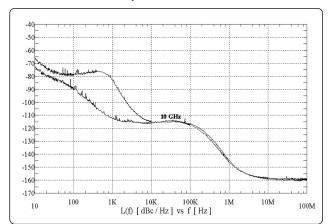


Option UNR with I/Q modulation on1

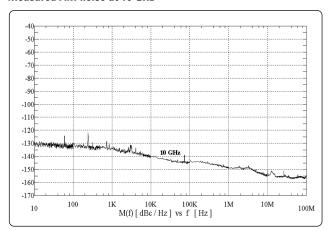


^{1.} External I/Q input level $\sqrt{(l^2 + Q^2)} = 250 \text{ mV}_{rms}$. I/Q modulator attenuator set to auto.

Measured standard vs. Option UNR at 10 GHz



Measured AM noise at 10 GHz



Typical rms jitter:1

Standard

Carrier	SONET/SDH	rms jitter	Unit intervals	Time
frequency	data rates	bandwidth	(μUI)	(fs)
155 MHz	155 MB/s	100 Hz to 1.5 MHz	95	497
622 MHz	622 MB/s	1 kHz to 5 MHz	54	55
2.488 GHz	2488 MB/s	5 kHz to 15 MHz	64	24
9.953 GHz	9953 MB/s	20 kHz to 80 MHz	162	16

Option UNR

Carrier	SONET/SDH	rms jitter	Unit intervals	Time	
frequency	data rates	bandwidth	(μUI)	(fs)	
155 MHz	155 MB/s	100 Hz to 1.5 MHz	85	400	
622 MHz	622 MB/s	1 kHz to 5 MHz	25	39	
2.488 GHz	2488 MB/s	5 kHz to 15 MHz	61	24	
9.953 GHz	9953 MB/s	20 kHz to 80 MHz	158	15	

Calculated from phase noise performance in CW mode only at +3 dBm. For other frequencies, data rate, or bandwidths, please contact your sales representative.

Frequency modulation

Maximum deviation	N x 8 MHz			
Resolution	0.1% of deviation or 1 Hz, whichever is greater			
Deviation accuracy		< ± 3.5% of FM deviation + 20 Hz		
		(1 kHz rate, dev	iations < N x 800 kHz)	
Modulation frequency re	esponse			
Path	Rates (at 100 k	Hz deviation)		
	1 dB Bandwidt	th	3 dB Bandwidth (typical)	
FM 1	dc/20 Hz to 100	kHz	dc/5 Hz to 10 MHz	
FM 2	dc/20 Hz to 100	kHz	dc/5 Hz to 1 MHz	
dc FM¹ carrier offset		±0.1% of set de	eviation + (N x 8 Hz)	
Distortion		< 1% (1 kHz rat	e, deviations < N x 800 kHz)	
Sensitivity		±1 V _{peak} for ind	icated deviation	
Paths		FM1 and FM2 a	are summed internally for composite	
		modulation. Eith	er path may be switched to any one of	
		the modulation sources: Ext1, Ext2, internal1, internal2.		
		The FM2 path is	s limited to a maximum rate of 1 MHz.	
		The FM2 path m	nust be set to a deviation less than FM1.	

Phase modulation

Maximum deviation		N x 80 radians	
		(N x 8 radians in high-bandwidth mode)	
Resolution	0.1% of set deviation		
Deviation accuracy	< ±5% of deviation + 0.01 radians		
		(1 kHz rate, normal BW mode)	
Modulation frequency	response		
Mode	Maximum Devi	viation Rates (3 dB BW)	
Normal BW	N x 80 rad	dc — 100 kHz	
High BW	N x 8 rad	dc – 1 MHz (typical)	
Distortion		< 1 % (1 kHz rate, THD, dev < N x 80 rad,	
		normal BW mode)	
Sensitivity		±1 V _{peak} for indicated deviation	

 Φ M1 and Φ M2 are summed internally for composite modulation. Either path may be switched to any one of the modulation sources: Ext1, Ext2, internal1, internal2. The Φ M2 path must be set to a deviation less than Φ M1.

Amplitude modulation $(f_c > 2 \text{ MHz})^2 \text{ (typical)}$

Paths

Depth	Linear mode		Exponential (log) mode
			(Downward modulation only)
Maximum	> 90%		> 20 dB
Settable ³	0 to 100 %		0 to 40 dB
Resolution	0.1%		0.01 dB
Accuracy (1 kHz rate)	$< \pm (6 \% \text{ of se})$	tting + 1 %)	$< \pm (2\% \text{ of setting} + 0.2 \text{ dB})$
Ext sensitivity	±1 V _{peak} for		-1 V for indicated depth
	indicated dept	h	
Rates (3 dB bandwidth,	30% depth)	dc/10 Hz to 1	100 kHz (typical) (useable to 1 MHz)
Distortion (1 kHz rate, I	inear mode, THD)		
30% AM		< 1.5%	
90% AM		< 4 %	
Paths		AM1 and AM	12 are summed internally for composite
		modulation. E	Either path may be switched to any one of
		the modulation	on sources: Ext1, Ext2, internal1, internal2.

^{1.} At the calibrated deviation and carrier frequency, within 5 °C of ambient temperature at time of user calibration.

For f_c < 2 MHz AM is usable but not specified. AM specifications apply with ALC on, and envelope peaks < maximum specified power.

^{3.} For AM depth settings > 90% or > 20 dB, deep AM mode or 1 kHz ALC BW is recommended.

Wideband AM

Rate (typical 1 dB bandwidth)		_
ALC on	1 kHz to 80 MHz	
ALC off	DC to 80 MHz	
External 1 input		
Sensitivity	0.5 V = 100%	
Input impedance	50 Ω (nominal)	

External modulation inputs (Ext1 & Ext2)

Modulation types	AM, FM, and ΦM
Input impedance	50 or 600 Ω (nominal), switched
High/low indicator	
(100 Hz to 10 MHz BW, ac coupled inputs only)	Activated when input level error exceeds 3% (nominal)

Simultaneous modulation

All modulation types may be simultaneously enabled except: FM with Φ M, linear AM with exponential AM, and Wideband AM with I/Q. AM, FM, and Φ M can sum simultaneous inputs from any two sources (Ext1, Ext2, internal1, or internal2) Any given source (Ext1, Ext2, internal1, or internal2) may be routed to only one activated modulation type.

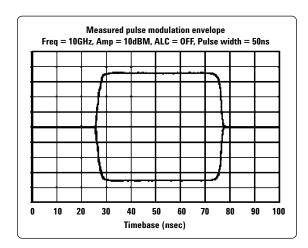
Internal modulation source

Dual function generators provides two independent signals (internal1 and internal2) for use with AM, FM, Φ M, or LF Out. Waveforms Sine, square, positive ramp, negative ramp, triangle, Gaussian noise, uniform noise, swept sine, dual sine 1 Rate range 0.5 Hz to 1 MHz Square, ramp, triangle 0.5 Hz to 100 kHz Resolution 0.5 Hz Accuracy Same as timebase LF out Output Internal1 or internal2. Also provides monitoring of internal 1 or internal 2 when used for AM, FM, or Φ M. Amplitude 0 to 3 V_{peak} , into 50 Ω (nominal) 50Ω (nominal) Output impedance Swept sine mode: (frequency, phase continuous) Operating modes Triggered or continuous sweeps Frequency range 1 Hz to 1 MHz Sweep rate 0.5 Hz to 100 kHz sweeps/s, equivalent to sweep times 10 us to 2 s Resolution 0.5 Hz (0.5 sweep/s)

^{1.} Internal2 is not available when using swept sine or dual sine modes.

Pulse modulation¹

			0
	Standard	Standard	Option 1E6 ²
	> 3.2 GHz	500 MHz to 3.2 GHz	10 MHz to 3.2 GHz
On/off ratio	80 dB	80 dB (typical)	80 dB
Rise/fall times (Tr, Tf)	10 ns (6 ns typical)	100 ns (typical)	10 ns (8 ns typical)
Pulse width			
Internally leveled	≥ 1µs	≥ 2 µs (typical)	≥ 1µs
Level hold (ALC Off	≥ 20 ns (typical)	≥ 0.5 µs (typical)	≥ 20 ns (typical)
with power search) 3			
Repetition frequency			
Internally leveled	10 Hz to 500 kHz	10 Hz to 250 kHz	10 Hz to 500 kHz
	(typical)	(typical)	(typical)
Level hold (ALC Off	dc to 10 MHz with	dc to 1 MHz (typical)	dc to 10 MHz (typical)
	(typical)		
power search) 3			
Level accuracy (relative	e to CW)		
Internally leveled	$\pm 0.5 \text{ dB}$	\pm 0.5 dB	\pm 0.5 dB
	±0.15 (typical)		
Level hold (ALC Off with	\leq 20 GHz \pm 0.8 dB	±0.5 dB (typical)	± 1.0 dB (typical)
power search) 3	(typical)		
Width compression	±5 ns (typical)	±50 ns (typical)	±5 ns (typical)
Video feed-through 4	< 2 mV (typical)	< 200 mV (typical)	< 125 mV (typical)
Video delay			
(Ext input to Video)	40 ns (nominal)	40 ns (nominal)	40 ns (nominal)
RF delay (Tm)			
(Video to RF output)	35 ns (nominal)	280 ns (nominal)	45 ns (nominal)
Pulse overshoot (Vor)	< 10% (typical)	< 10% (typical)	< 1 GHz 20% (typical)
, ,		. ,,	≥ 1 GHz 10% (typical)
Input level	+1 V _{peak} = RF On	+1 V _{peak} = RF On	+1 V _{peak} = RF On
Input impedance	50Ω , (nominal)	50Ω , (nominal)	50Ω , (nominal)



^{1.} With ALC off, specs apply after the execution of power search. Specs apply with Atten Hold off (default mode), or ALC level between 0 and +10 dBm.

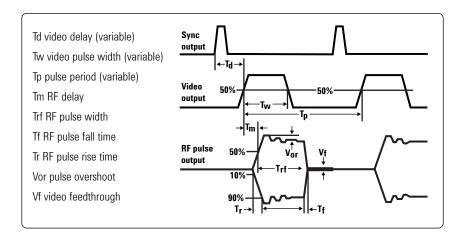
^{2.} Option 1E6 provides narrow pulse (20 ns typical) capability between 10 MHz and 3.2 GHz. Narrow pulse capability above 3.2 GHz is standard.

Power search is a calibration routine that improves level accuracy in ALC-off mode. Un-pulsed RF power will be present typically up to 50 ms when executing power search.

With attenuator in 0 dB position. Video feed-through decreases with attenuator setting.

Internal pulse generator

Modes	Free-run, triggered, triggered with delay, doublet,	
	and gated. Triggered with delay, doublet, and gated	
	require external trigger source.	
Period (PRI) (Tp)	70 ns to 42 s	
	(Repetition frequency: 0.024 Hz to 14.28 MHz)	
Pulse width (Tw)	10 ns to 42 s	
Delay (Td)		
Free-run mode	0 to \pm 42 s	
Triggered with delay and doublet modes	75 ns to 42 s with ±10 ns jitter	
Resolution	10 ns (width, delay, and PRI)	



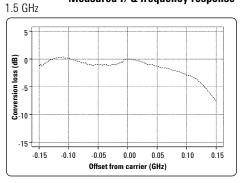
Vector modulation

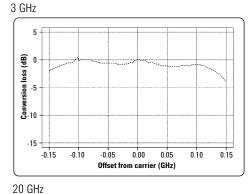
External I/Q inputs

Input impedance switched 50 or 600 Ω (nominal) Input range 1 Minimum 0.1 V_{rms} , maximum $1V_{peak}$

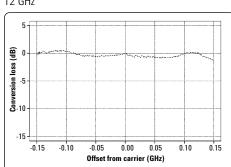
± 1 dB within ± 40 MHz of carrier (with ALC off) (typical) Flatness

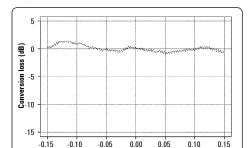
Measured I/Q frequency response 2





12 GHz





Offset from carrier (GHz)

Vector accuracy³ Formats: BPSK, QPSK, 16-256QAM $(\alpha = 0.3, Root Nyquist filter, symbol rate 4 Msym/s)$ **EVM** <1.2% RMS, < 0.8% RMS (typical) Origin offset 250 kHz to 3.2 GHz -45 dBc (typical) 3.2 to 20 GHz -50 dBc (typical)

I/Q adjustments

I & O offsets	External inputs (600 Ω) \pm 5 Volts
	External inputs (50 Ω) \pm 50 %
	Internal baseband generator ± 50 %
I/O attenuation	0 to 40 dB

I/Q gain balance \pm 4 dB I/Q quadrature skew ± 10° range (typical)

Low pass filter Selectable 40 MHz or through

I/Q baseband outputs

Differential I, I bar, Q, Q bar I, Q

Single ended

DC to 40 MHz Frequency range $\begin{array}{l} 1.5 \ V_{p\text{-}p} \ (typical) \\ \pm \ 3 \ V \end{array}$ Output voltage into 50 W

DC offset adjustments DC offset resolution 1 mV

Low pass filter Selectable 40 MHz or though

For optimum signal quality, the I and Q inputs should be 0.7 V_{peak} , with $\sqrt{(I^2 + Q^2)} + 150 \text{ mV}_{rms}$. Different RMS levels are accommodated by adjusting the internal I/Q modulator attenuator, which may be either manually or automatically set. The minimum input level required to maintain RF level accuracy is $\sqrt{(l^2 + 0^2)} = 0.1 \text{ V}_{rms}$. Sine wave response, measured with input level = 100 mV_{rms} on one channel, and ALC off.

Measured with Agilent 89441A Vector Signal Analyzer. Valid after executing I/Q calibration, and instrument is maintained within \pm 5 °C of calibration temperature. RF power < 0 dBm. External I/Q input level $\sqrt{(l^2 + Q^2)}$ = $0.3 V_{rms}$, I/Q modulator attenuator = 10 dB.

I/Q baseband generator: arbitrary waveform mode

(Option 602)

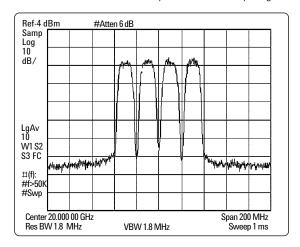
Channels	2 [I and Q]
Resolution	16 bits [1/65,536]
Baseband waveform memory	
Length (playback)	64 megasamples (MSa)
Length (storage)	1.2 gigasamples (GSa) on 6 GB hard drive (Option 005)
Waveform segments	
Segment length	60 samples to 64 MSa
Maximum number of segments	4,096
Minimum memory allocation	256 samples or 1 kbyte blocks
Waveform sequences	
Maximum total number of segments	16,384
Sequencing	Continuously repeating
Maximum number of sequences	16,384
Maximum segments/sequence	1 to 32,768
Maximum segment repetitions	1 to 65,536
Clock	
Sample rate	1 Hz to 100 MHz
Resolution	0.001 Hz
Accuracy	Same as timebase +2 ⁻⁴² [in non-integer applications]
Reconstruction filter: [fixed]	50 MHz [used for all symbol rates]
Baseband spectral purity	
[full scale sinewave]	
Harmonic distortion	100 kHz to 2 MHz: < -65 dBc (typical)
Phase noise	< -127 dBc/Hz (typical)
	(baseband output of 10 MHz sinewave at 20 kHz offset)
IM performance	< -74 dB (typical)
	(two sinewaves at 950 kHz and 1050 kHz at baseband)
Triggers	
Types	Continuous, single, gated, segment advance
Source	Trigger key, external, remote [LAN, GPIB, RS-232]
External polarity	Negative, positive
External delay time	10 ns to 40 sec plus latency
External delay resolution	10 ns
Markers	

(Markers are defined in a segment during the waveform generation process, or from the PSG front panel. A marker can also be tied to the RF blanking feature of the PSG.)

Marker polarity	Negative, positive
Number of markers	4
Multicarrier	
Number of carriers	Up to 100 (limited by a max bandwidth of 80 MHz depending on symbol rate and modulation type)
Frequency offset (per carrier)	–40 MHz to +40 MHz
Power offset (per carrier)	0 dB to -40 dB
Modulation	
PSK	BPSK, QPSK, OQPSK, $\pi/4$ DQPSK, 8PSK,16PSK, D8PSK
QAM	4, 16, 32, 64, 256
FSK	Selectable: 2, 4, 8, 16
MSK	
Data	Random ONLY

Measured multicarrier

4 Carriers with 64 QAM at 10 Msym\s with 20 MHz spacing

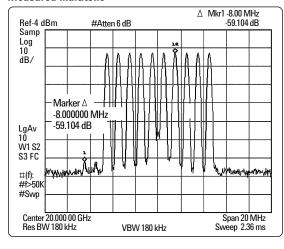


Multitone

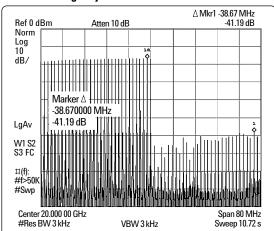
Number of tones 2 to 64, with selectable on/off state per tone

Frequency spacing 100 Hz to 80 MHz Phase (per tone) Fixed or random Power offset (per tone) 0 to $-40~\mathrm{dB}$

Measured multitone



Measured image rejection > 3.2 GHz



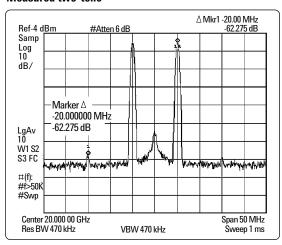
Two-tone

Frequency spacing 100 Hz to 80 MHz (symmetrical about carrier)

IM distortion

250 kHz to 3.2 GHz \$<-45 dBc for RF levels < 0dBm (typical) > 3.2 GHz to 20 GHz \$<-55 dBc for RF levels < 0dBm (typical)

Measured two-tone



Internal baseband generator: real-time mode

(Option 602)

Design and ulation toward (quotom format)	
Basic modulation types (custom format)	, DODON
PSK BPSK, QPSK, 0QPSK, π/4DQPSK, 8PSK, 16PSK	., D8PSK
MSK User-defined phase offset from 0 to 100°	
QAM 4, 16, 32, 64, 256	
FSK Selectable: 2, 4, 8, 16 level symmetric	
User defined Custom map of up to 16 deviation levels	
Symbol rate Maximum deviation	
< 5 MHz 4 times symbol rate	
5 MHz to 50 MHz 20 MHz	
Resolution: 0.1 Hz	
I/Q Custom map of 256 unique values	
FIR filter	
Selectable Nyquist, root Nyquist, Gaussian, rectangular	
α : 0 to 1, B _b T: 0.1 to 1	
Custom FIR 16-bit resolution, up to 64 symbols long, autom	atically
resampled to 1024 coefficients (max)	
> 32 to 64 symbol filter: symbol rate ≤12.5 MF	łz
> 16 to 32 symbol filter: symbol rate ≤25 MHz	
Internal filters switch to 16 tap when symbol ra	te is
between 25 and 50 MHz	
Symbol rate	
For external serial data: Adjustable from 1000 symbols/sec to a maximu	ım symbol
rate of 50 Mbits/sec - #bits/symbol	
For internally generated data: Adjustable from 1000 symbols/sec to 50 Msym	bols/sec.
and a maximum of 8 bits per symbol. Modulation	on quality
may be degraded at high symbol rates.	. ,
Baseband reference frequency Data clock can be phase locked to an external in	eference.
Input ECL, CMOS, TTL compatible, 50 Ω AC coupled	
Frame trigger delay control	
Range 0 to 1,048,575 bits	

Data types

Internally generated data

Pseudo-random patterns PN9, PN11, PN15, PN20, PN23

Repeating sequence Any 4-bit sequence Other fixed patterns

Direct-pattern RAM [PRAM]

Max size 32 Mb

(each bit uses an entire sample space)

Use Non-standard framing

User file

Max size 3.2 MB

Use Continuous modulation or internally generated

TDMA standard

Externally generated data

Type Serial data

Inputs Data, data (bit) clock, symbol sync

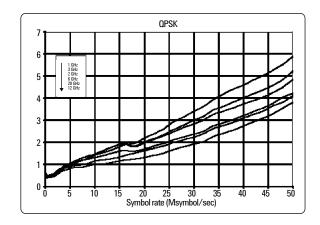
Accepts data rates ±5% of specified data rate

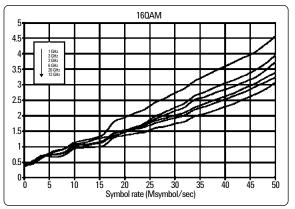
Internal burst shape control

Varies with standards and bit rates

Rise/fall time range Up to 30 bits
Rise/fall delay range 0 to 63.5 bits

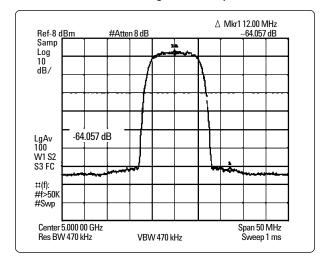
Measured EVM





Measured spectral re-growth

5 GHz carrier with 16 QAM signal at 10 Msym/s



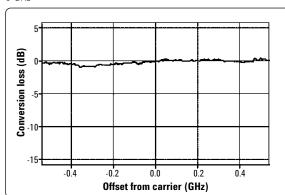
Wideband external I/Q inputs

(Option 015)

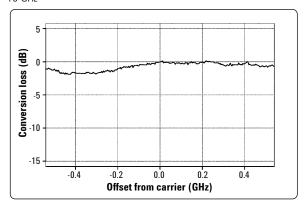
RF output frequency range:	3.2 to 20 GHz	
Input		
Input (baseband) frequency range	DC to > 500 MHz (nominal)	
Input impedance	50 Ω (nominal)	
Recommended input level	0 dBm (nominal)	
Maximum input voltage	±1 volt DC	
I/Q offset adjustments	±50%	
RF path filters ¹		
Carrier Frequency	Low-pass 3 dB cutoff frequency (nominal)	
>3.2 to 5 GHz	5.5 GHz	
>5 to 8 GHz	8.9 GHz	
> 8 to 12.8 GHz	13.9 GHz	
> 12.8 GHz	22.5 GHz	

Measured I/Q frequency response

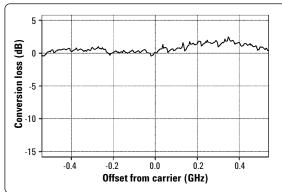
6 GHz



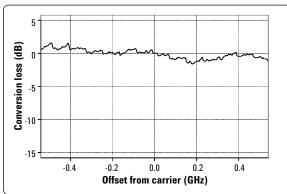
10 GHz











Operation close to RF filter cutoff frequencies will affect channel flatness.

Remote programming

Interfaces	GPIB (IEEE-488.2,1987) with listen and talk, RS-232,
	and 10BaseT LAN interface.
Control languages	SCPI version 1997.0. Also will emulate most applicable
	Agilent 836xxB, Agilent 837xxB, and Agilent 8340/41B
	commands, providing general compatibility with ATE
	systems which include these signal generators.
IEEE-488 functions	SH1, AH1, T6, TE0, L4, LE0, SR1, RL1, PP0, DC1, DT0, C0, E2.
ISO compliant	This family of signal generators is manufactured in an
	ISO-9001 registered facility in concurrence with
	Agilent Technologies commitment to quality.

General specifications

Power requirements	90 to 267 Vac 50 to 60 Hz, (automatically selected),
·	650 W maximum.
Operating temperature range	0 to 55 °C1
Storage temperature range ²	−40 to 71 °C
	With Option 005: -4 ° to 65 °C, gradient less than
	20 °C/hour
Shock and vibration	
Operating random vibration	5 to 500 Hz, 0.21 g rms
Survival swept sine vibration	5 to 500 Hz, 0.75 g
Survival random vibration	5 to 500 Hz, 2.09 g rms
Functional shock (half-sine, 30 g, 11 ms)	Meets the requirements of MIL-PRF-28800F for class
and bench drop test	3 equipment.
EMC	Meets the conducted and radiated interference and
	immunity requirements of IEC/EN 61326-1.
	Meets radiated emission requirements of CISPR Pub 11/1997
	Group 1 class A.
Storage registers	Memory is shared by instrument states, user data files,
	sweep list files, and waveform sequences. Depending on
	the number and size of these files, up to 800 storage
	registers and 10 register sequences are available.
Security	Display blanking.
Compatibility	Agilent Technologies 83550 Series millimeter heads (not
	for use with I/Q modulation), Agilent Technologies 8757D
	scalar network analyzers, Agilent Technologies EPM
	Series power Meters.
Self-test	Internal diagnostic routine tests most modules (including
	microcircuits) in a preset condition. For each module, if its
	node voltages are within acceptable limits, then the
	module "passes" the test.
Weight	< 25 kg (54 lb.) net, < 33 kg (74 lb.) shipping.
Dimensions	178 mm H x 426 mm W x 498 mm D
	(7" H x 16.8" W x 19.6" D in.).
Recommended calibration cycle	24 months

Input/Output **Descriptions**

Front panel connectors

(All connectors are BNC female unless otherwise noted.) ³

RF output	Nominal output impedance 50 Ω . Precision APC-3.5
	male, or Type-N with Option 1ED.
ALC input	Used for negative external detector leveling.
	Nominal input impedance 120 k Ω , damage level ± 15 V.
LF output	Outputs the internally generated LF source. Nominal
	output impedance 50 Ω .

^{1.} Save and recall of user files and instrument states from Option 005 Hard Drive is guaranteed only over the

Storage below –20 °C instrument states may be lost.
 Digital inputs and output are 3.3 V CMOS unless indicated otherwise. Inputs will accept 5 V CMOS, 3V CMOS, or TTL voltage levels.

External input 2	Drives either AM, FM, or Φ M. Nominal input impedance
	50 or 600 Ω , damage levels are 5 V_{rms} and 10 V_{peak} .
Pulse/trigger gate input	Accepts input signal for external fast pulse modulation.
	Also accepts external trigger pulse input for internal pulse
	modulation. Nominal impedance 50 Ω . Damage levels
	are 5 V _{rms} and 10 V _{peak} .
Pulse video out	Outputs a signal that follows the RF output in all pulse
	modes. TTL-level compatible, nominal source impedance 50 Ω .
Pulse sync out	Outputs a synchronizing pulse, nominally 50 ns width,
	during internal and triggered pulse modulation. TTL-level
	compatible, nominal source impedance 50 Ω .
Data clock input	Accepts a data clock signal to synchronize serial data for use
	with internal baseband generator (Option 602). Maximum
	rate 50 MHz. Damage levels are $> + 5.5$ and < -0.5 V.
Data input	Accepts serial data for use with internal baseband generator
	(Option 602). Maximum rate 50 Mb/s. Data must be valid
	on the falling edges of data clock (normal mode) or the
	symbol sync (symbol mode). Damage levels are $> +5.5$
	and <-0.5 V.
l input	Accepts an "I" input either for I/Q modulation or for
-	wideband AM. Nominal input impedance 50 or 600 Ω .
	Damage levels are 1 V _{rms} and 5 V _{peak} .
Q input	Accepts a "Q" input for 1/0 modulation. Nominal input
	impedance 50 or 600 Ω . Damage levels are 1 V_{rms} and
	5 V _{peak} .
Symbol sync input	Accepts symbol sync signal for use with internal baseband
	generator (Option 602). Symbol sync might occur once
	per symbol or be a single, one bit wide pulse to synchronize
	the first bit of the first symbol. Maximum rate 50 MHz.
	Damage levels are $>+5.5$ and <-0.5 V.

Rear panel connectors

(All connectors are BNC female unless otherwise noted.) ¹

Auxillary interface (Dual mode)	Used for RS-232 serial communication and for Master/Slave
,	source synchronization. (9-pin D-subminiature female
	connector) For Master/Slave operation use Agilent
	Technologies part #8120-8806 Master/Slave interface cable.
GPIB	Allows communication with compatible devices.
LAN	Allows 10baseT LAN communication
10 MHz input	Accepts an external reference (timebase) input (at 1, 2, 2.5, 5, 10 MHz for standard and 10 MHz only for Option UNR) Nominal input impedance 50 Ω .
40.101	Damage levels > +10 dBm
10 MHz output	Outputs internal or external reference signal. Nominal output impedance 50 Ω . Nominal output power +4 dBm
Sweep output (Dual mode)	Supplies a voltage proportional to the RF power or frequency sweep ranging form 0 volts at the start of sweep to +10 volts (nominal) at the end of sweep, regardless of sweep width.
	When connected to an Agilent 8757D scalar network analyzer (Option 007), generates a selectable number of equally spaced 1 us pulses (nominal) across a ramp (analog) sweep. Number of pulses can be set form 101 to 1601 by remote control from the 8757D.
	Output impedance: < 1 Ω , can drive 2000 Ω .

^{1.} Digital inputs and output are 3.3 V CMOS unless indicated otherwise. Inputs will accept 5 V CMOS, 3V CMOS, or TTL voltage levels.

Stop sweep In/Out	Open-collector, TTL-compatible input/output. In ramp sweep operation, provides low level (nominally 0 V) during sweep retrace and bandcross intervals, and high level during the forward portion of the sweep. Sweep will stop when grounded externally, sweep will resume when allowed to go high.
Trigger output (Dual mode)	Outputs a TTL signal. High at start of dwell, or when waiting for point trigger; low when dwell is over or point trigger is received, In ramp sweep mode, provides 1601 equally-spaced 1us pulses (nominal) across a ramp sweep. When using LF out, provides 2 us pulse at start of LF sweep.
Trigger input	Accepts TTL signal for triggering point-to-point in manual sweep mode, or to trigger start of LF sweep. Damage levels $\geq +10 \text{ V}$ or $\leq -4 \text{ V}$.
Source module interface	Provides bias, flatness correction, and leveling connections to the Agilent model 83550 Series mm-wave source modules.
Source settled	Provides an output trigger that indicates when the signal generator has settled to a new frequency or power level. High indicates source not settled, Low indicates source settled.
Z-axis Blank/Markers	During ramp sweep, supplies + 5 V (nominal) level during retrace and bandswitch intervals. Supplies – 5 V (nominal) level when the RF frequency is at a marker frequency.
EFC	$>$ 0.25 ppm for -5 to $+5$ V Input impedance: $>$ 1 M Ω
.25 – 3.2 GHz coherent carrier output	Outputs RF signal modulated with FM or Φ M but not I/O, AM or pulse. Nominal power 0 dBm. Frequency range from 250 MHz to 3.2 GHz. Not useful for output frequency > 3.2 GHz. Damage levels 20 Vdc and 13 dBm reverse RF power. (SMA female)
Baseband generator reference input	Accepts 0 to + 20 dBm sinewave, or TTL squarewave, reference input to use as reference clock for the baseband generator (Option 602). Phase locks the internal data generator to the external reference: the RF frequency is still locked to the 10 MHz reference. Rate is 250 kHz to 100 MHz 50 Ω (nominal), AC coupled.
Burst gate input	Accepts signal for gating burst power for use with internal baseband generator (Option 602). The burst gating is used when you are externally supplying data and clock information. The input signal must be synchronized with the external data input that will be output during the burst. The burst power envelope and modulated data are internally delayed and re-synchronized. The input signal must be CMOS high for normal burst RF power or CW RF output power and CMOS low for RF off. Damage levels are >+5.5 and <-0.5 V.
Event 1 output	In real-time mode, outputs a pattern or frame synchronization pulse for triggering or gating external equipment, for use with internal baseband generator (Option 602). May be set to start at the beginning of a pattern, frame, or timeslot and is adjustable to within \pm one timeslot with one bit resolution. In arbitrary waveform mode, outputs a timing signal generated by marker 1.
Event 2 output	In real-time mode, outputs a data enable signal for gating external equipment, for use with internal baseband generator (Option 602). Applicable when external data is clocked into internally generated timeslots. Data is enabled when signal is low. In arbitrary waveform mode, outputs a timing signal generated by marker 2.

I and Q outputs	Outputs the analog I/Q modulation signals from the internal
	baseband generator. Nominal output impedance 50 Ω ,
	DC-coupled. Damage levels ±3.5 V.
Tand Q outputs	Outputs the complement of the I and Q signals for
	differential applications. Nominal output impedance 50 Ω ,
	DC-coupled. Damage levels ±3.5 V.
Pattern trigger input	Accepts signal to trigger internal pattern or frame generator
	to start single pattern output, for use with internal baseband
	generator (Option 602). Minimum pulse width 100 ns.
	Damage levels are $>+5.5$ and <-0.5 V.
Wideband I and Q inputs	Direct high-bandwidth analog inputs to I/Q modulator in
	3.2 to 20 GHz range. Not calibrated. 0 dBm maximum.
	(Option 015 only)
	· · · · · · · · · · · · · · · · · · ·

Auxiliary I/O connector (37-pin) used with Option 602

Alternate power input	Accepts CMOS signal for synchronization of external data
	and alternate power signal timing. Damage levels are
	>+8 and <-4V.
Data clock output	Relays a CMOS bit clock signal for synchronizing serial data.
Data output	Outputs data from the internal data generator or the
	externally supplied signal at data input. CMOS signal.
Event 3 output	In arbitrary waveform mode, outputs a timing signal
	generated by marker 3. Damage levels >+8 and <4 V.
Event 4 output	In arbitrary waveform mode, outputs a timing signal
	generated by marker 4. Damage levels >+8 and <4 V.
Symbol sync output	Outputs CMOS symbol clock for symbol synchronization,
	one data clock period wide.

Options, Accessories, and Related Products

Model/option	Description
E8267C-520	Frequency range 250 kHz to 20 GHz
E8267C-003	Enables digital output connectivity with N5102A
E8267C-UNR	Enhanced close-in phase noise
E8267C-1E6	Narrow pulse modulation below 3.2 GHz
E8267C-007	Ramp (analog) sweep
E8267C-602	Internal baseband generator, 64 MSa memory
E8267C-005	6 GB internal hard drive
E8267C-015	Wideband external I/Q inputs
E8267C-1ED	Type-N (f) connector
E8267C-1EM	Moves all connectors to rear panel
E8267C-1CM	Rack mount kit
E8267C-1CN	Front handle kit
E8267C-1CP	Rack mount kit with front handle kit
E8267C-408	Signal Studio software for enhanced multitone signals
E8267C-420	Signal Studio software for pulse building
E8267C-421	Signal Studio software for noise power ratio
83554A	Millimeter-wave source module (26.5 to 40 GHz)
83555A	Millimeter-wave source module (33 to 50 GHz)
83556A	Millimeter-wave source module (40 to 60 GHz)
83557A	Millimeter-wave source module (50 to 75 GHz)
83558A	Millimeter-wave source module (75 to 110 GHz)
8120-8806	Master/slave interface cable
N5102A	Baseband Studio digital signal interface module
N5101A	Baseband Studio PCI card
N5110A	Baseband Studio for waveform streaming
N5110A-120	Hard drive waveform streaming up to 20 MSa/s
N5110A-121	Extend hard drive streaming BW from 20 MSa/s up to 40 MSa/s
N5110A-125	Signal generator hard drive streaming connectivity
9211-2656	Standard transit case
9211-7481	Tote-style transit case (includes wheels and telescoping handles)

Web Resources

www.agilent.com/find/psg www.agilent.com/find/basebandstudio www.agilent.com/find/signalstudio

Related Agilent Literature

PSG Signal Generator, Brochure Literature number: 5988-7538EN

E8247C/57C PSG CW and Analog Signal Generator, Data Sheet Literature number 5988-7454EN

E8267C PSG Vector Signal Generator Data Sheet Literature number 5988-6632EN

PSG Self Guided Demo Literature number 5988-2414EN

E8267C PSG Vector Signal Generator Configuration Guide Literature number 5988-7541EN

PSG Series: Millimeter Head, Product Note Literature number 5988-2567EN

PSG Two-tone and Multitone Personalities
Application Note AN 1410
Literature number: 5988-7689EN

Signal Studio for Noise Power Ratio
Technical Overview
Literature number 5988-9161EN

Signal Studio for Enhanced Multitone Technical Overview Literature number 5988-5639EN

Baseband Studio Digital Signal Interface Module Technical Overview Literature number 5988-9495EN

Baseband Studio for Waveform Streaming Technical Overview Literature number: 5988-9493EN

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